

PATENT APPLICATION *TPW* *#*

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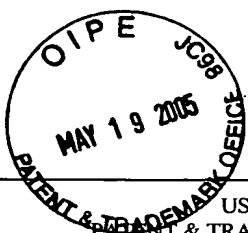
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Sheet 1 of 1

Form PTO-1449 (REV. 8-83)			US Dept. of Commerce PATENT & TRADEMARK OFFICE		ATTY DOCKET NO. 118952		APPLICATION NO. 10/797,150	
INFORMATION DISCLOSURE STATEMENT  (Use several sheets if necessary)								
			APPLICANT(S) Takeshi UEMATSU et al.					
			FILING DATE March 11, 2004			GROUP 2838		
<b>U.S. PATENT DOCUMENTS</b>								
EXAMINER INITIAL		DOCUMENT NUMBER	DATE	NAME			CLASS	SUB CLASS
<b>FOREIGN PATENT DOCUMENTS</b>								
		DOCUMENT NUMBER	DATE	COUNTRY			CLASS	SUB CLASS
		JP 2000-116182 w/Abstract	04/21/2000	Japan				
<b>OTHER DOCUMENTS (Including Author, Title, Date, Pertinent Pages, etc.)</b>								
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